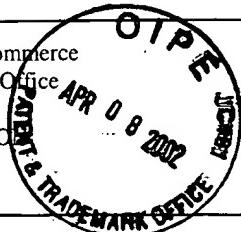


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Attorney Docket No.: 0941.63365

Serial No.: 09/425,788

Applicant: Abarra et al.

Filing Date: October 22, 1999

Group: 1773

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						Yes	No
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Examiner

*H. L. Lohr*

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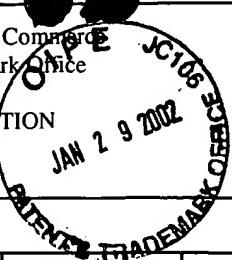
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Examiner

*H. L. L.*

Date Considered

*5/27/02*

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		Applicant: Abarra et al.	
		Filing Date: October 22, 1999	Group No.: 1773

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*H. Wilson* 5/27/02